Flash in vehicles: end-user's perspective



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<u>Automotive flash needs</u>

- Robustness:
 - temperature
 - vibration
- Predictability:
 - read-write transaction time
 - component lifetime
- Visibility:
 - health statistics
 - testability

SMART monitoring of SSD

SMART Attributes Data Structure revision number: 1

NAME	VALUE	WORS	T THRESH	TYPE	
RAW_VALUE					
Reallocated_Sectors	100	100	010	Pre-fail	0
PowerOn_Hours	099	99	000	Old_age	157
Power_Cycle_Cnt	099	99	000	Old_age	15
Wear_Leveling_Cnt	100	100	000	Pre-fail	0
Program_Fail_Cnt	100	100	010	Old_age	0
Erase_Fail_Count	100	100	010	Old_age	0
Runtime_Bad_Block	100	100	010	Pre-fail	0
Uncorrectable_Errors	100	100	000	Old_age	0
Airflow_Temperature	67	64	000	Old_age	33
ECC_Error_Rate	200	200	000	Old_age	0
CRC_Error_Count	100	100	000	Old_age	0
POR_Recovery_Cou	nt 99	99	000	Old_age	10
Total_LBAs_Written	99	99	000	Old_age	204813376

Compare auto-grade SPI-NOR

```
root@nitrogen:~# ls /sys/class/mtd/mtd0
bad blocks
                   device
                                   flags
                                                    oobsize
                                                                 type
bbt blocks
                   ecc failures
                                  mtdblock0
                                                                 uevent
                                                    power
        threshold
                                                    size
                                                                 writesize
                   ecc step size name
corrected bits
                   ecc strength
                                  numeraseregions
                                                    subpagesize
                   erasesize
                                  offset
                                                    subsystem
aev
root@nitrogen:~# cat /sys/class/mtd/mtd0/type
nor
root@nitrogen:~# cat /sys/class/mtd/mtd0/size
786432
root@nitrogen:~# cat /sys/class/mtd/mtd0/bad_blocks
```

Much less information!

<u>Unmet need: storage EVMs</u>



OM13081 - Evaluation Module, Sensing, Touch, Proximity, Capacitive Touch, 8bit Touchpad w / 9 Keys, LCD

Clustered or distributed architectures?

http://tinyurl.com/ybovp4lb

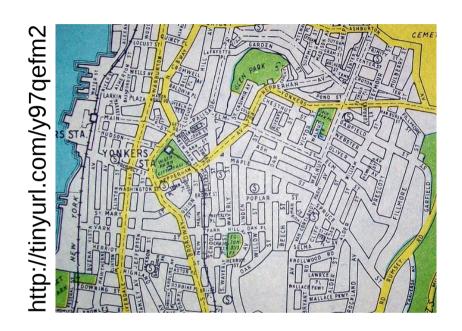


- -- More storage devices, near sensors and actuators.
- -- Filter sensor data before fusing.
- -- Slower buses, shorter latency?
- -- Higher BOM?

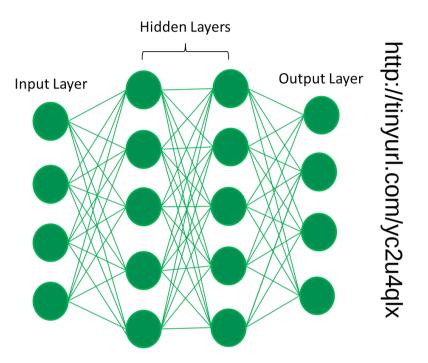


- -- Fewer, larger devices.
- -- Transfer data before processing.
- -- Needs faster network, virtualization.
- -- Unproven in production.

<u>Map- or model-based decisions?</u>



- -- Based on 'knowing where you are'.
- -- Big database of locally cached results.



- -- Based on 'what I can see.'
- -- Small database of model coefficients.

Summary

- Most important: reliability, predictability, testability.
- Manufacturers have some opportunities to improve usability.
- Vehicle system architecture choices influence flash requirements.